CORRECTED SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION					ATTY. DOCKET NO. 60188-629		HAL NO 635,64 9			
					APPLICANT Koei HATADE, et a					
		(PT	O-1449)	· ·	FILING DATE August 07, 2003	■ · · · · · · · · · · · · · · · · · · ·				
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

SHEET 1 OF 1

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					APPLICANT Koei HATADE, et al.					
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